

SCH1410-TL-E-VB Datasheet N-Channel 30 V (D-S) MOSFET

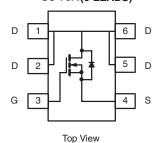
PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^{a, e}	Q _g (Typ.)		
30	0.023 at V _{GS} = 10 V	3	4.2 nC		
	0.027 at V _{GS} = 4.5 V	3	4.2110		

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- Low On-Resistance
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC



SC-75A(6-LEADS)



APPLICATIONS

• DC/DC Converters, High Speed Switching

ABSOLUTE MAXIMUM RATIN	GS (T _A = 25 °C	, unless othe	rwise noted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		3 ^e		
Continuous Drain Current (T. – 150 °C)	T _C = 70 °C	1 . [3 ^e		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C		2.5 ^{b, c}		
	T _A = 70 °C	1	2.2 ^{b, c}	A	
Pulsed Drain Current (t = 300 μs)		I _{DM}	25		
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	2.1		
	T _A = 25 °C	l _S	1.1 ^{b, c}		
	T _C = 25 °C		2.5		
Maximum Power Dissipation	T _C = 70 °C	P _D	1.6	w	
	T _A = 25 °C		1.3 ^{b, c}	VV	
	T _A = 70 °C	1	0.8 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature)			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	75	100	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	40	50		

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c t = 5 s
- d. Maximum under steady state conditions is 166 °C/W.
- e. Package limited.

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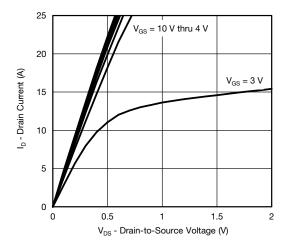
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						-1	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		30		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	1 _D = 230 μA		- 4.8			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.2		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	V _{DS} = 30 V, V _{GS} = 0 V		1		
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α	
Dania Carras Car Otata Daniata and	В	$V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$		0.023		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 2 \text{ A}$		0.027			
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 2.5 \text{ A}$		24		S	
Dynamic ^b	1			•			
Input Capacitance	C _{iss}			424		pF	
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		100			
Reverse Transfer Capacitance	C _{rss}			42			
Total Gate Charge	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$		8.2	13	nC	
				4.2	7		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 2.5 \text{ A}$		1.4			
Gate-Drain Charge	Q _{gd}			1.4			
Gate Resistance	R _g	f = 1 MHz	2.5	12.6	25.2	Ω	
Turn-On Delay Time	t _{d(on)}			6	12	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 3.4 Ω		20	30		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		14	21		
Fall Time	t _f			10	20		
Turn-On Delay Time	t _{d(on)}			3	6		
Rise Time	t _r	V_{DD} = 15 V, R_L = 3.4 Ω		11	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 2.4 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		20	30		
Fall Time	t _f			7	14		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			2.1	۸	
Pulse Diode Forward Current	I _{SM}				25	A	
Body Diode Voltage	V _{SD}	I _S = 2.4 A, V _{GS} = 0 V		0.82	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			13	20	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 2.4 A, dI/dt = 100 A/μs, T _J = 25 °C		6	12	nC	
Reverse Recovery Fall Time	t _a	iF = 2.4 A, αί/αι = 100 A/μS, 1J = 25 °C		8			
everse Recovery Rise Time t _b				5		ns	

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

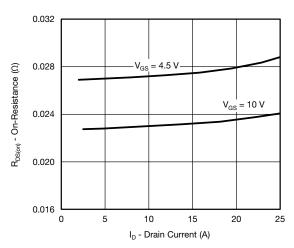
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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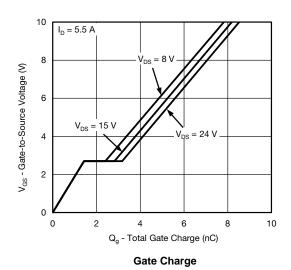




Output Characteristics

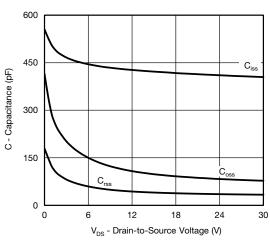


On-Resistance vs. Drain Current and Gate Voltage

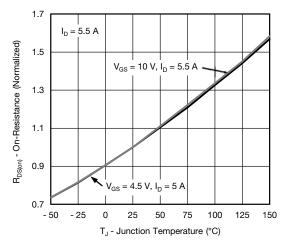


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Transfer Characteristics

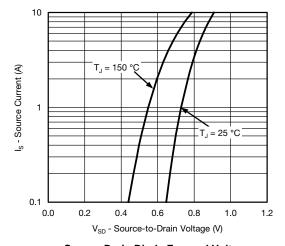


Capacitance

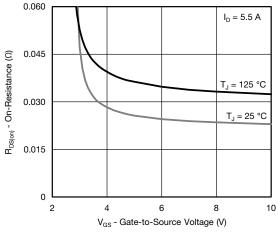


On-Resistance vs. Junction Temperature

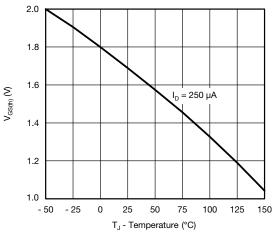




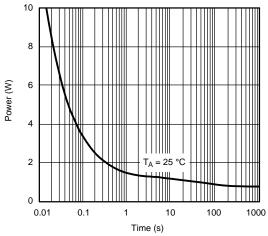
Source-Drain Diode Forward Voltage



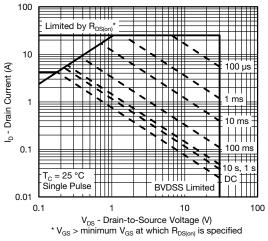
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

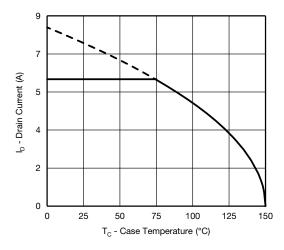


Single Pulse Power (Junction-to-Ambient)

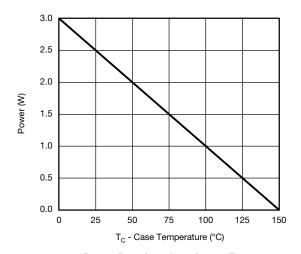


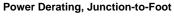
Safe Operating Area, Junction-to-Ambient

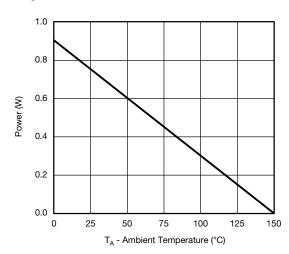




Current Derating*





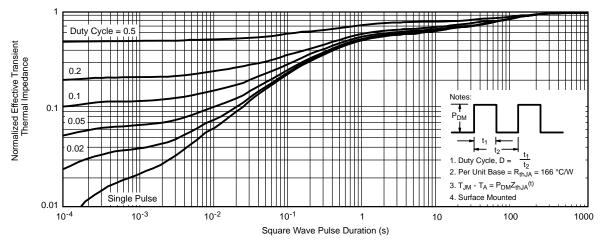


Power Derating, Junction-to-Ambient

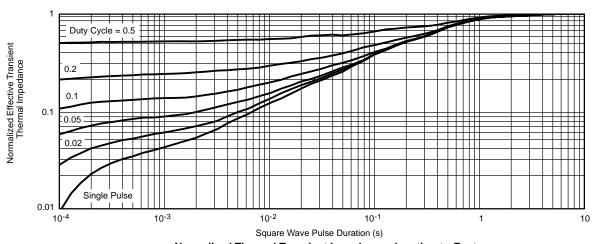
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^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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